In Place of FORM PTO-1449 (Modified)

Serial No. _____
Applicant: Paolini et al.

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

Filing Date: _____
Group: _____
Atty. Docket No. AUS920030341US1

Reference Designation

U. S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
/A.F./	AA 6,590,604 B1	7/8/2003	Tucker et al.	348	14.13	4/7/2000
	AB					

FOREIGN PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation Yes No
/A.F./	AC WO 02/39371 A2	5/16/2002	Netherland	G06K	9/00	
/A.F./	AD WO 02/099784 A1	12/12/2002	Netherland	G10L	13/02	
/A.F./	AE WO 02/42909 A1	5/30/2002	Netherland	G06F	9/44	
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner Initial	
/A.F./	AL *Facial Expression Analysis*, by Cohn et al.
/A.F./	AM *Beyond Voice Recognition: Facial Expression Decoding*, Technical Insights Alert, December 31, 1999
/A.F./	AN *Expression Glasses: A Wearable Device for Facial Expression Recognition*, by Scheirer et al., MIT Media Laboratory
/A.F./	AO *Interpretations*, DataFace, Psychology, Appearance and Behavior of the Human Face
/A.F./	AP *Comprehensive Database for Facial Expression analysis*, by Takeo Kanade, Jeffrey F. Cohn and Yingli Tian
/A.F./	AR *Bimodal Expression of Emotion by Face and Voice*, by Jeffrey F. Cohn and Gary S. Katz
/A.F./	AS *Recognizing Action Units for Facial Expression Analysis*, by Yingli Tian, Takeo Kanade and Jeffrey F. Cohn, IEEE Transactions on Pattern Analysis and Machine Intelligence, Vol. 23, No. 2, February 2001

Examiner: /Atiba Fitzpatrick/   Date Considered: 02/01/2008

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /A.F./